



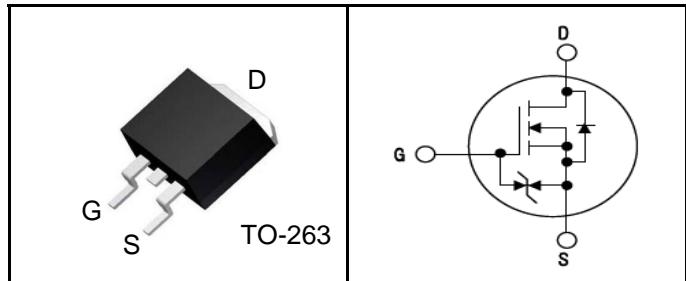
迈威电源

MPSC65M210B

## 650V N-Channel Super Junction MOSFET

### Features

- $V_{DSS}=650V$ ,  $I_D=16.8A$
- $R_{DS(on)}:0.21\Omega$  (Max) @  $V_{GS}=10V$
- Very Low FOM ( $R_{DS(on)} \times Q_g$ )
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested
- Built-in ESD Diode



### Application

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- AC to DC Converters
- Telecom, Solar

RoHS

### Device Marking and Package Information

Ordering code	Package	Marking
MPSC65M210B	TO-263	MP65M210B

### Absolute Maximum Ratings

 $T_c=25^\circ C$  unless otherwise specified

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain-Source Voltage	650	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Drain Current - Continuous ( $T_c = 25^\circ C$ )	16.8 *	A
	Drain Current - Continuous ( $T_c = 100^\circ C$ )	10.6 *	A
$I_{DM}^1$	Drain Current - Pulsed	50 *	A
$E_{AS}^2$	Single Pulsed Avalanche Energy	250	mJ
$I_{AR}$	Avalanche Current	2.4	A
$dv/dt$	MOSFET $dv/dt$ ruggedness, $V_{DS}=0\dots 400V$	50	V/ns
$dv/dt$	Reverse diode $dv/dt$ , $V_{DS}=0\dots 400V$ , $I_{DS} \leq I_D$	15	V/ns
$P_D$	Power Dissipation ( $T_c = 25^\circ C$ )	105	W
$V_{ESD(G-S)}$	Gate source ESD(HBM-C=100pF, R=1.5KΩ)	2000	V
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	°C

\* Drain current limited by maximum junction temperature

### Thermal Resistance Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient , Max.	62	°C/W



迈普斯科技

MPSC65M210B

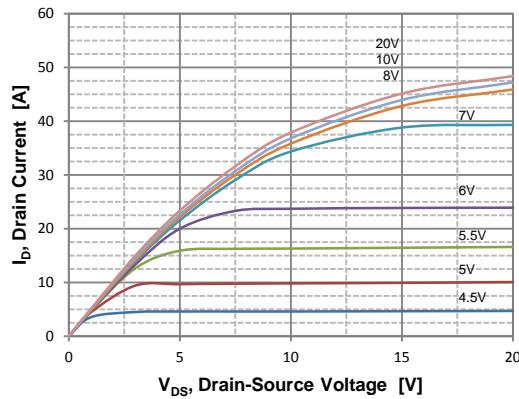
**Electrical Characteristics**  $T_J=25\text{ }^{\circ}\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
<b>On Characteristics</b>						
$V_{GS}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 670\text{ }\mu\text{A}$	2.0	-	4.0	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}$ , $I_D = 6.2\text{ A}$	-	0.185	0.21	$\Omega$
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}$ , $I_D = 1\text{ mA}$	650	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 650\text{ V}$ , $V_{GS} = 0$	-	-	1	$\mu\text{A}$
		$V_{DS} = 650\text{ V}$ , $T_C = 150\text{ }^{\circ}\text{C}$	-	-	100	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 20\text{ V}$ , $V_{DS} = 0\text{ V}$	-	-	$\pm 1$	$\mu\text{A}$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS} = 400\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 1.0\text{ MHz}$	-	1750	-	pF
$C_{oss}$	Output Capacitance		-	39	-	pF
$C_{rss}$	Reverse Transfer Capacitance		-	3.4	-	pF
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Time	$V_{DS} = 325\text{ V}$ , $I_D = 8.7\text{ A}$ , $R_G = 25\text{ }\Omega$ (Note 3,4)	-	39	-	ns
$t_r$	Turn-On Rise Time		-	21	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	171	-	ns
$t_f$	Turn-Off Fall Time		-	18	-	ns
$Q_g$	Total Gate Charge	$V_{DS} = 520\text{ V}$ , $I_D = 8.7\text{ A}$ , $V_{GS} = 10\text{ V}$ (Note 3,4)	-	40	-	nC
$Q_{gs}$	Gate-Source Charge		-	8	-	nC
$Q_{gd}$	Gate-Drain Charge		-	12	-	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Drain-Source Diode Forward Current	-	-	16.8	A	
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current	-	-	50	A	
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}$ , $I_S = 8.7\text{ A}$	-	-	1.3	V
$trr$	Reverse Recovery Time	$V_R = 400\text{ V}$ , $I_F = 8.7\text{ A}$ $dI/dt = 100\text{ A}/\mu\text{s}$	-	340	-	ns
$Qrr$	Reverse Recovery Charge		-	4.7	-	$\mu\text{C}$

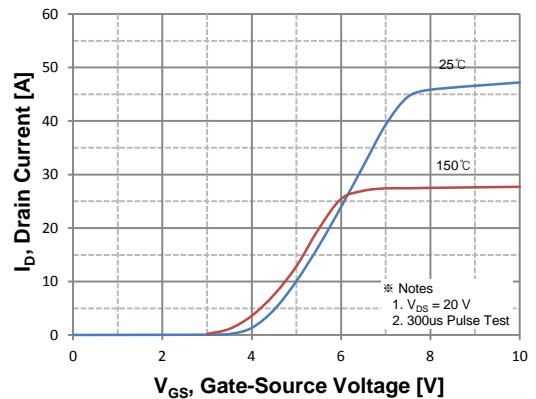
**Notes :**

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $I_{AS}=2.4\text{ A}$   $V_{DD}=50\text{ V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25\text{ }^{\circ}\text{C}$
- Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- Essentially Independent of Operating Temperature

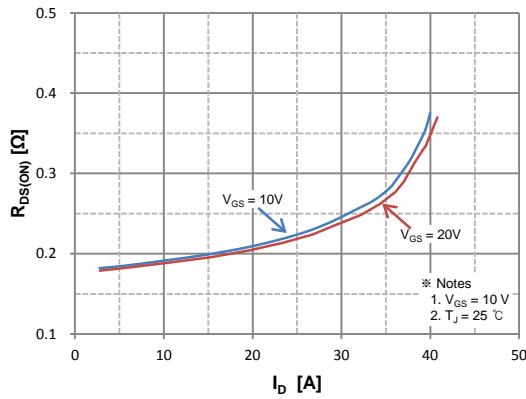
## Typical Characteristics



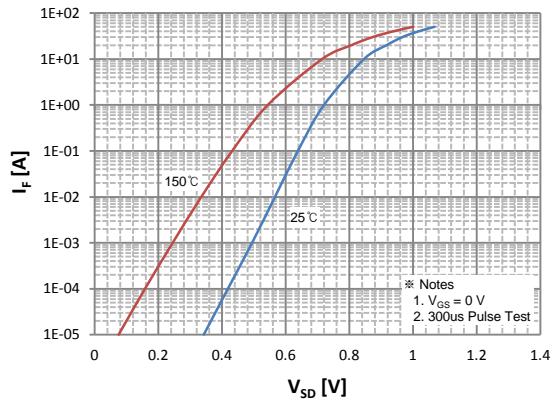
**Figure 1. On Region Characteristics**



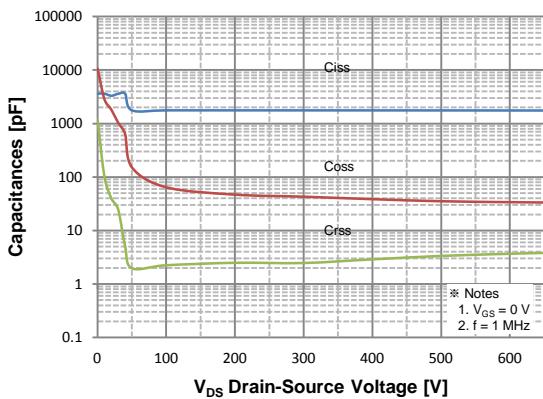
**Figure 2. Transfer Characteristics**



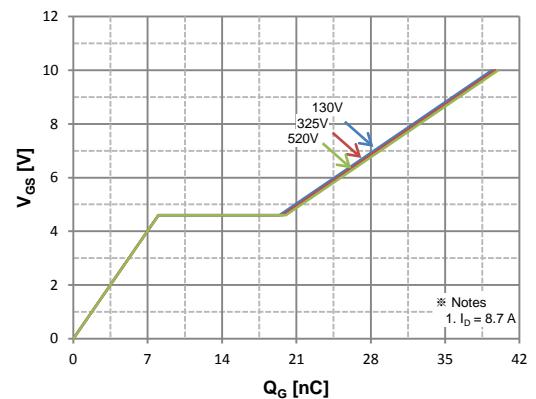
**Figure 3. On Resistance Variation vs Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

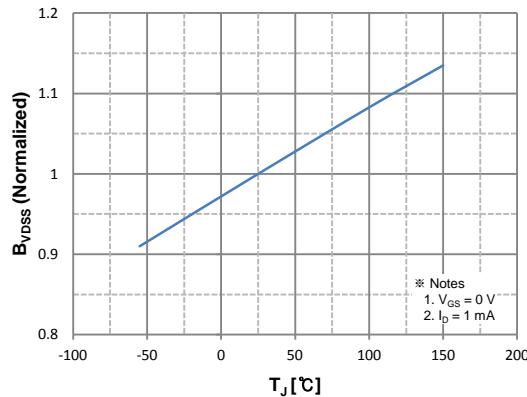


**Figure 5. Capacitance Characteristics**

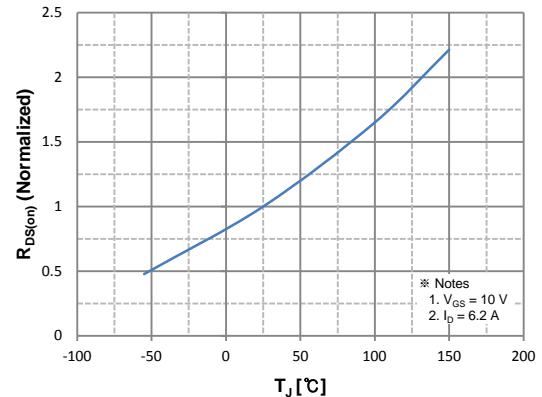


**Figure 6. Gate Charge Characteristics**

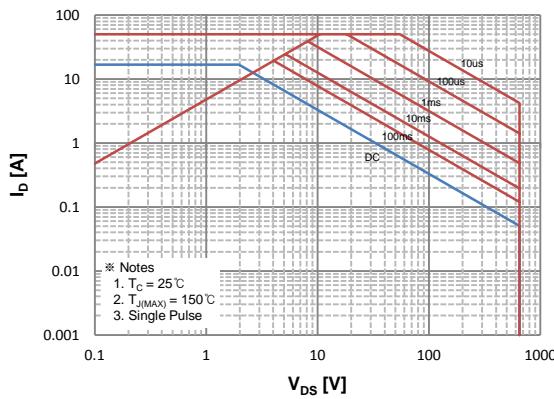
## Typical Characteristics



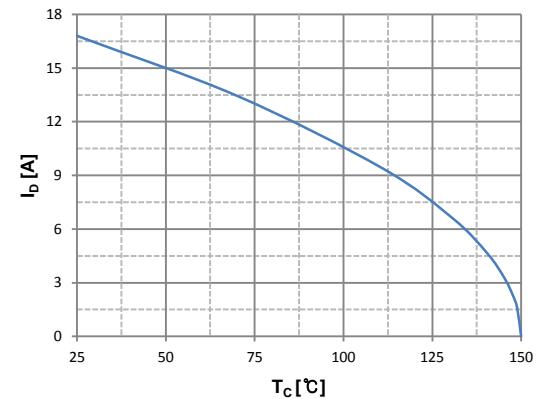
**Figure 7. Breakdown Voltage Variation  
vs. Temperature**



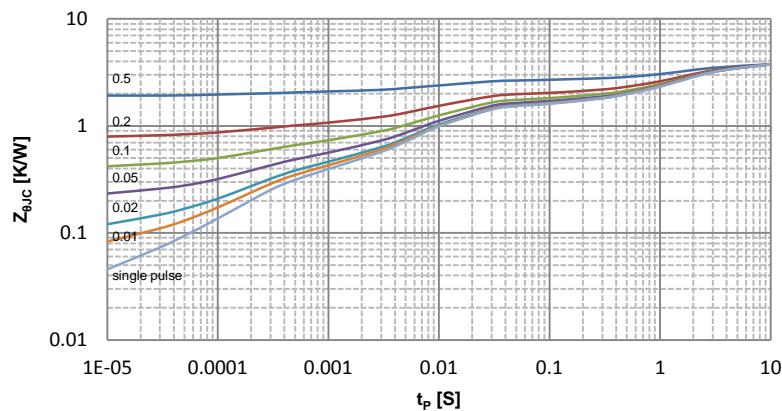
**Figure 8. On-Resistance Variation  
vs. Temperature**



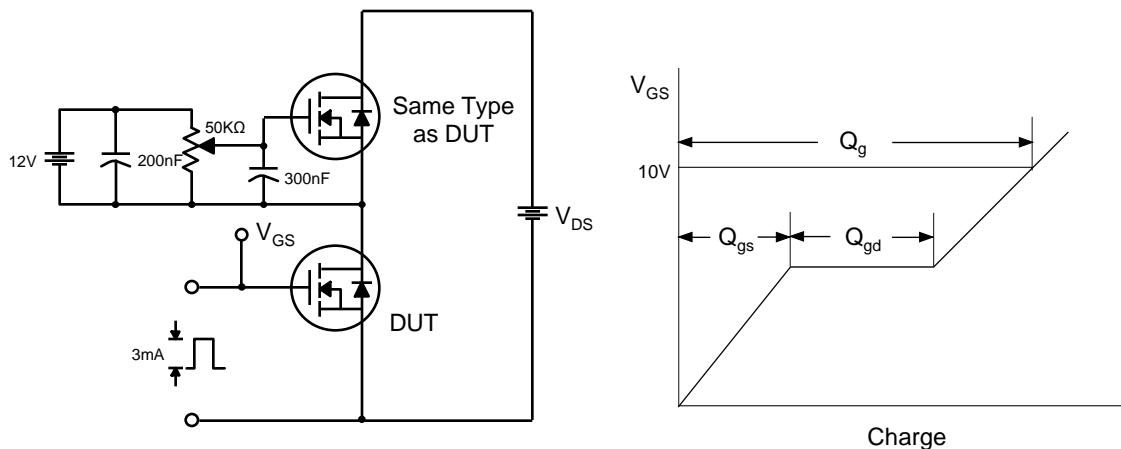
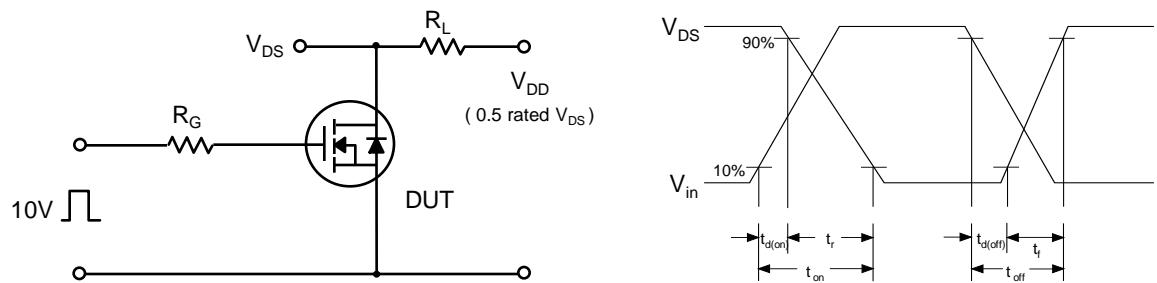
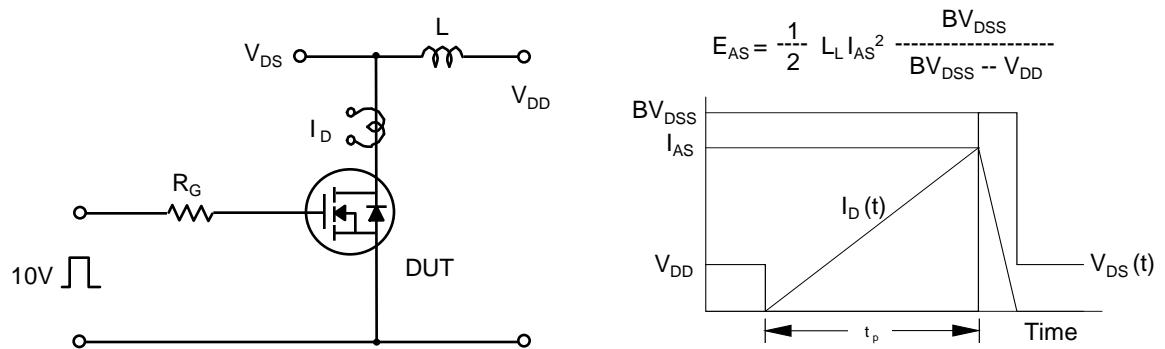
**Figure 9. Maximum Safe Operating Area**

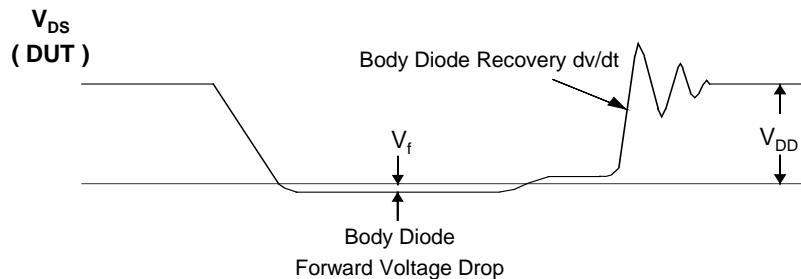
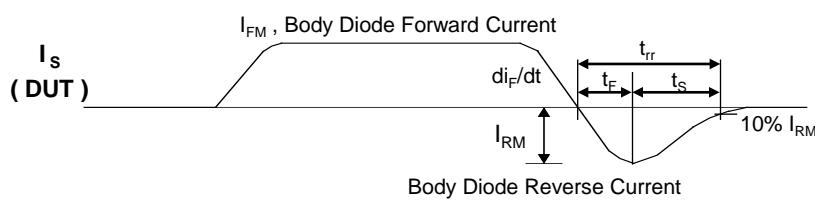
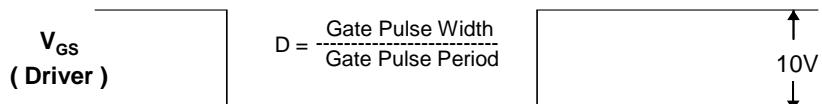
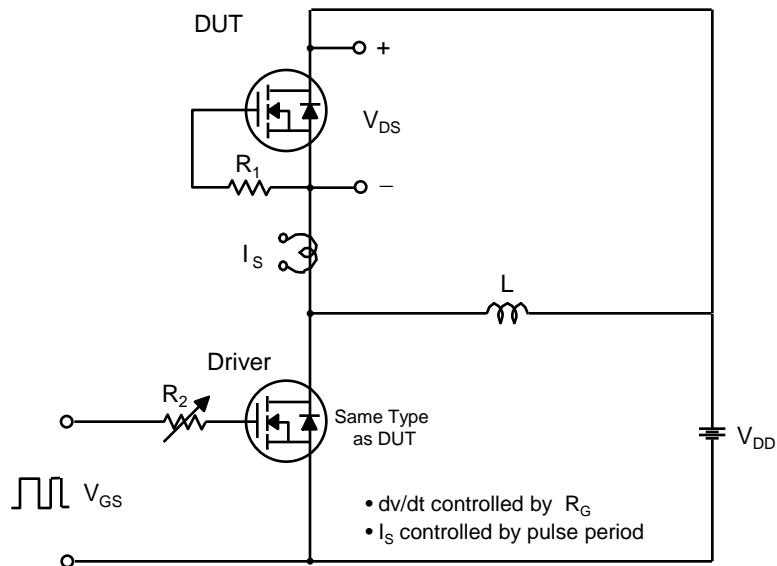


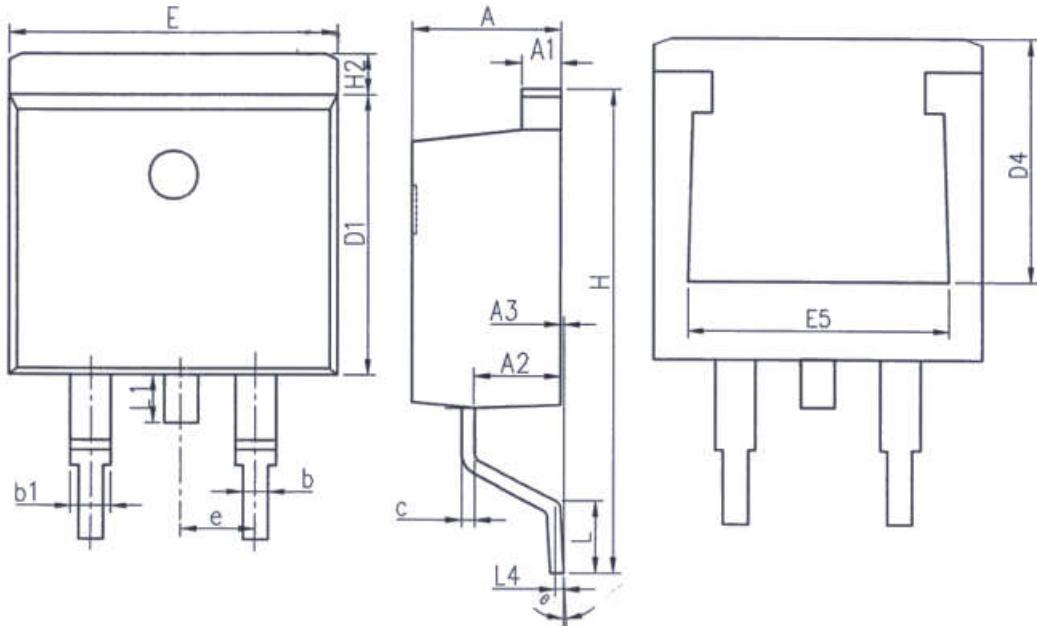
**Figure 10. Maximum Drain Current  
vs. Case Temperature**



**Figure 11. Transient Thermal Response Curve**

**Fig 12. Gate Charge Test Circuit & Waveform**

**Fig 13. Resistive Switching Test Circuit & Waveforms**

**Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms**


**Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms**


**TO-263**


Unit: mm		
Symbol	Min.	Max.
A	4.37	4.77
A1	1.22	1.42
A2	2.49	2.89
A3	0.00	0.25
b	0.70	0.96
b1	1.17	1.47
c	0.30	0.53
D1	8.50	8.90
D4	6.60	-

Unit: mm		
Symbol	Min.	Max.
E	9.86	10.36
E5	7.06	-
e	2.54BSC	
H	14.70	15.50
H2	1.07	1.47
L	2.00	2.60
L1	1.40	1.70
L4	0.25BSC	
θ	0°	9°